



<IGBT Modules>

CM100MXUC-24T/CM100MXUCP-24T

**HIGH POWER SWITCHING USE
INSULATED TYPE**

 <p>MXUC</p>	<p>Collector current I_c 1 0 0 A Collector-emitter voltage V_{CES} 1 2 0 0 V Maximum junction temperature T_{vjmax} 1 7 5 °C</p> <ul style="list-style-type: none"> •Flat base type •Copper base plate (Nickel-plating) •RoHS Directive compliant •Tin-plating pin terminals
 <p>MXUCP</p>	<p>Collector current I_c 1 0 0 A Collector-emitter voltage V_{CES} 1 2 0 0 V Maximum junction temperature T_{vjmax} 1 7 5 °C</p> <ul style="list-style-type: none"> •Flat base type •Copper base plate (Nickel-plating) •RoHS Directive compliant •Tin-plating pressfit terminals <p>.....</p> <ul style="list-style-type: none"> •UL Recognized under UL1557, File No. E323585

CIB (Converter+Inverter+Chopper Brake)

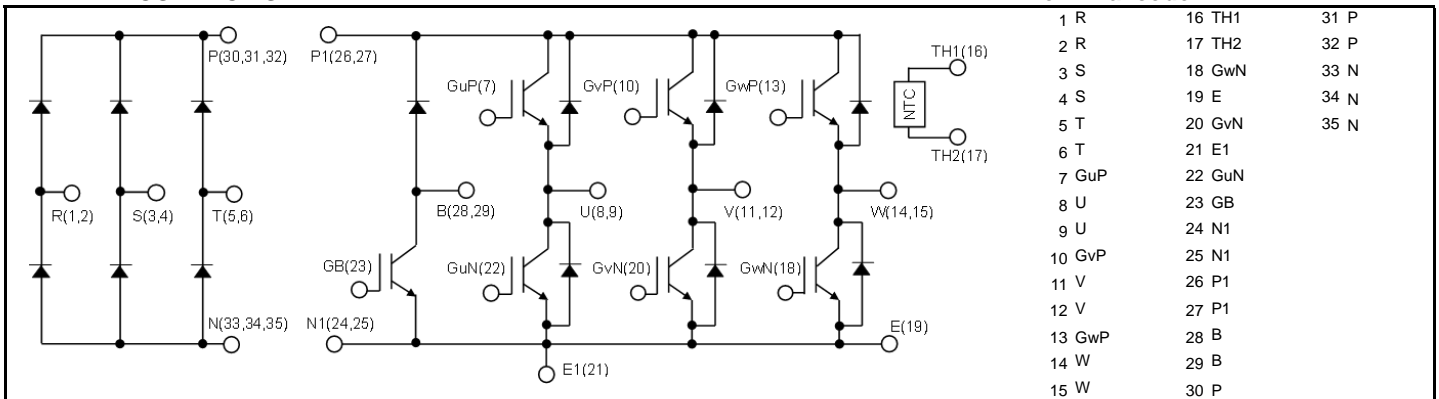
APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.

OPTION (Below options are available.)

- PC-TIM (Phase Change Thermal Interface Material) pre-apply

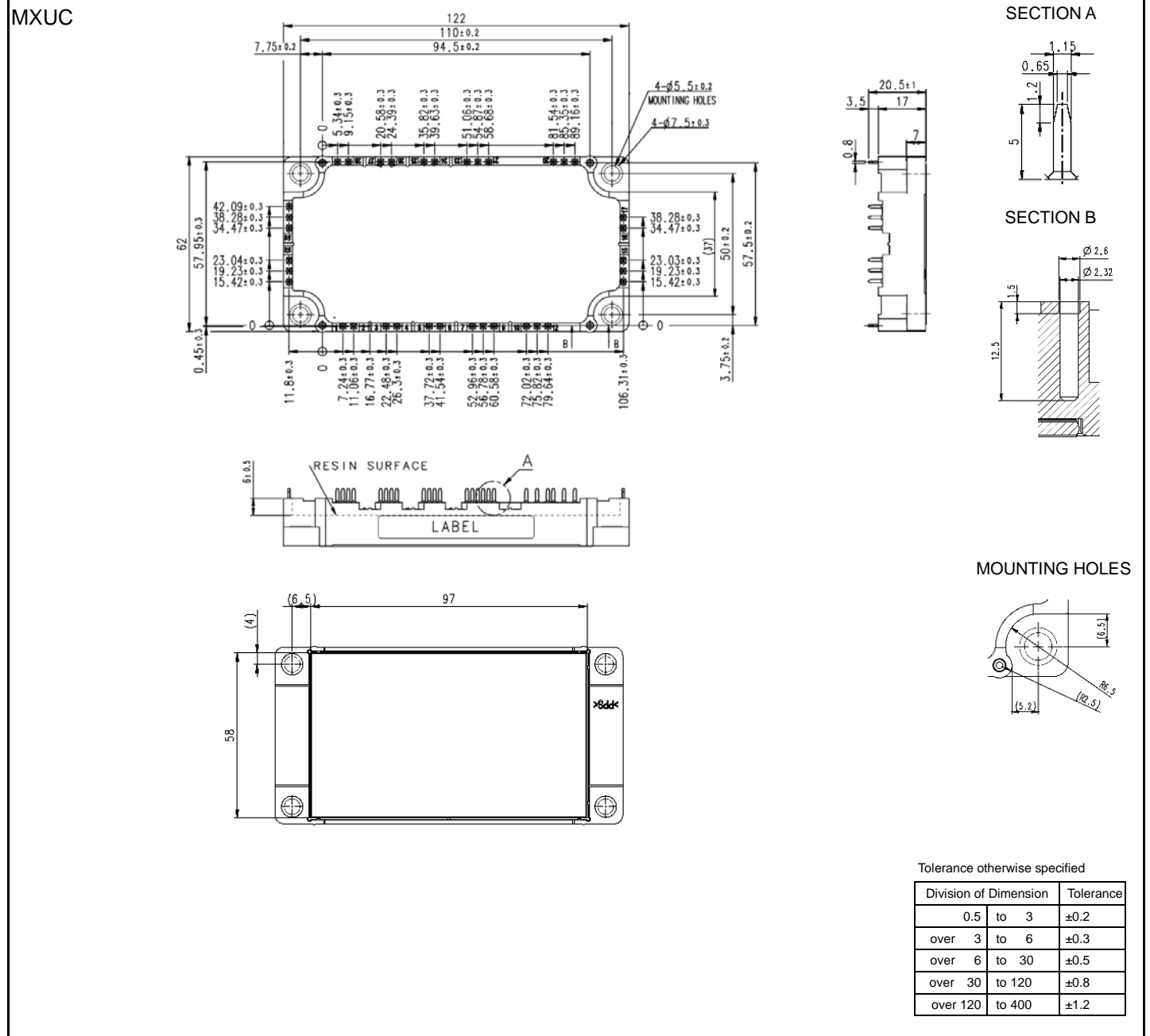
INTERNAL CONNECTION



CM100MXUC-24T/CM100MXUCP-24T

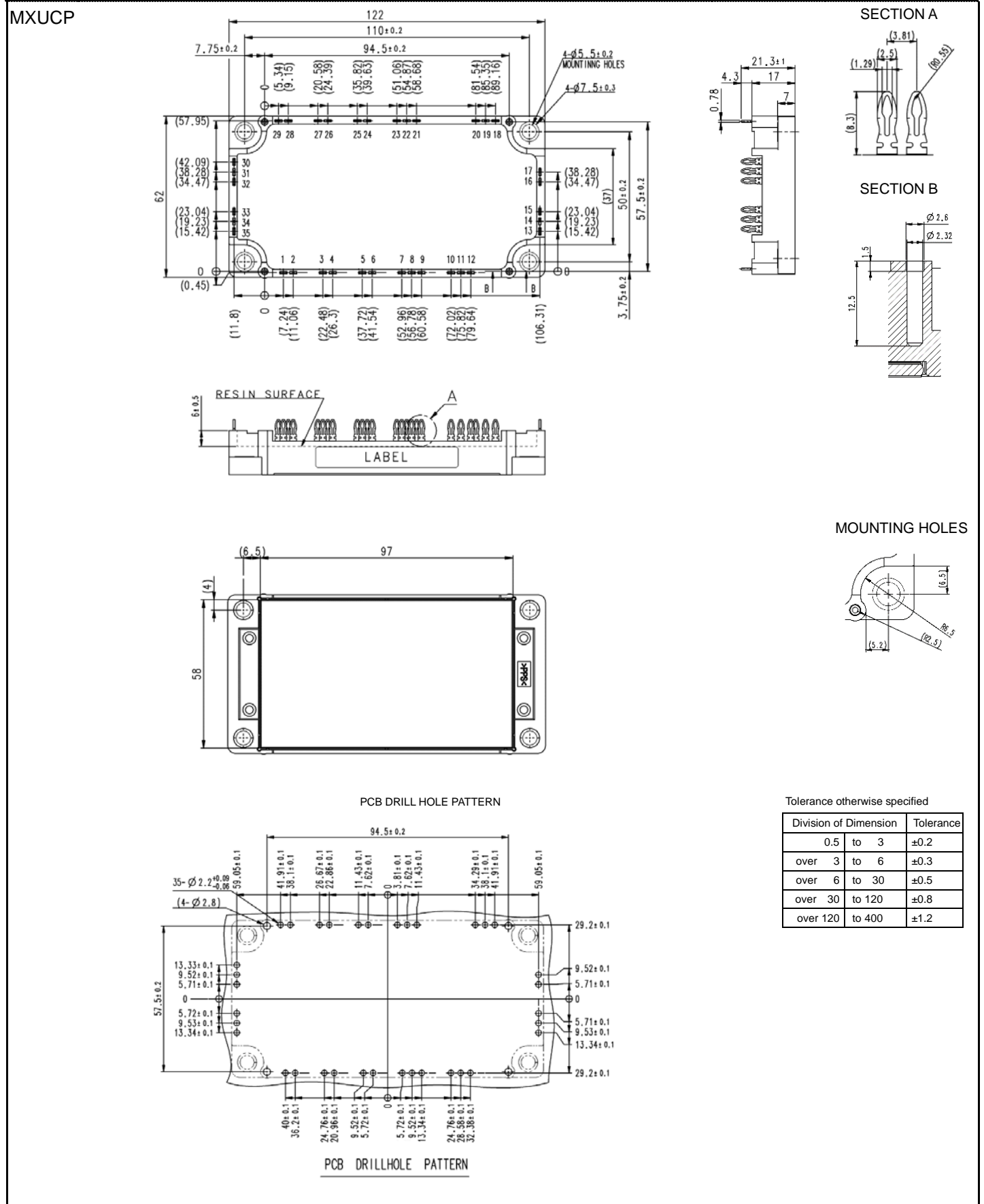
HIGH POWER SWITCHING USE
INSULATED TYPE

OUTLINE DRAWING



<IGBT Modules>
CM100MXUC-24T/CM100MXUCP-24T
 HIGH POWER SWITCHING USE
 INSULATED TYPE

OUTLINE DRAWING



CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE**MAXIMUM RATINGS (T_{vj}=25 °C, unless otherwise specified)****INVERTER PART IGBT/FWD**

Symbol	Item	Conditions	Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V _{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I _C	Collector current	DC, T _C =119 °C (Note2, 4)	100	A
I _{CRM}		Pulse, Repetitive (Note3)	200	
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	565	W
I _E (Note1)	Emitter current	DC (Note2)	100	A
I _{ERM} (Note1)		Pulse, Repetitive (Note3)	200	
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions	Rating	Unit
V _{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V _{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I _C	Collector current	DC, T _C =120 °C (Note2, 4)	75	A
I _{CRM}		Pulse, Repetitive (Note3)	150	
P _{tot}	Total power dissipation	T _C =25 °C (Note2, 4)	440	W
V _{RRM}	Repetitive peak reverse voltage	G-E short-circuited	1200	V
I _F	Forward current	DC (Note2)	50	A
I _{FRM}		Pulse, Repetitive (Note3)	100	
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload)	175	°C

CONVERTER PART DIODE

Symbol	Item	Conditions	Rating	Unit	
V _{RRM}	Repetitive peak reverse voltage	-	1600	V	
E _a	Recommended AC input voltage	RMS	440	V	
I _o	DC output current	3-phase full wave rectifying, T _C =125 °C (Note4)	100	A	
I _{FSM}	Surge forward current	The sine half wave 1 cycle peak value, f=60 Hz, non-repetitive	T _{vj} =25 °C	1200	A
			T _{vj} =150 °C	960	
I ² _t	Current square time	Value for one cycle of surge current	T _{vj} =25 °C	6000	A ² s
			T _{vj} =150 °C	3840	
T _{vjmax}	Maximum junction temperature	Instantaneous event (overload)	150	°C	

MODULE

Symbol	Item	Conditions	Rating	Unit
V _{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	2500	V
T _{Cmax}	Maximum case temperature	(Note4)	125	°C
T _{vjop}	Operating junction temperature	Continuous operation (under switching)	-40 ~ +150	°C
T _{stg}	Storage temperature	-	-40 ~ +125	

CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE**ELECTRICAL CHARACTERISTICS (T_{vj}=25 °C, unless otherwise specified)**
INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I _{CEs}	Collector-emitter cut-off current	V _{CE} =V _{CEs} , G-E short-circuited	-	-	1.0	mA	
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited	-	-	0.5	μA	
V _{GE(th)}	Gate-emitter threshold voltage	I _C =10 mA, V _{CE} =10 V	5.4	6.0	6.6	V	
V _{CEsat} (Terminal)	Collector-emitter saturation voltage	I _C =100 A, V _{GE} =15 V, Refer to the figure of test circuit (Note5)	T _{vj} =25 °C	-	1.75	2.20	V
			T _{vj} =125 °C	-	2.10	-	
			T _{vj} =150 °C	-	2.20	-	
V _{CEsat} (Chip)	Collector-emitter saturation voltage	I _C =100 A, V _{GE} =15 V, (Note5)	T _{vj} =25 °C	-	1.55	1.80	V
			T _{vj} =125 °C	-	1.75	-	
			T _{vj} =150 °C	-	1.80	-	
C _{ies}	Input capacitance	V _{CE} =10 V, G-E short-circuited	-	-	24.2	nF	
C _{oes}	Output capacitance		-	-	0.7		
C _{res}	Reverse transfer capacitance		-	-	0.3		
Q _G	Gate charge	V _{CC} =600 V, I _C =100 A, V _{GE} =15 V	-	0.75	-	μC	
t _{d(on)}	Turn-on delay time	V _{CC} =600 V, I _C =100 A, V _{GE} =±15 V, R _G =3.9 Ω, Inductive load	-	-	300	ns	
t _r	Rise time		-	-	150		
t _{d(off)}	Turn-off delay time		-	-	500		
t _f	Fall time		-	-	400		
V _{EC} (Note1) (Terminal)	Emitter-collector voltage	I _E =100 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T _{vj} =25 °C	-	1.80	2.35	V
			T _{vj} =125 °C	-	2.00	-	
			T _{vj} =150 °C	-	2.05	-	
V _{EC} (Note1) (Chip)	Emitter-collector voltage	I _E =100 A, G-E short-circuited, (Note5)	T _{vj} =25 °C	-	1.55	2.00	V
			T _{vj} =125 °C	-	1.55	-	
			T _{vj} =150 °C	-	1.55	-	
t _{rr} (Note1)	Reverse recovery time	V _{CC} =600 V, I _E =100 A, V _{GE} =±15 V, R _G =3.9 Ω, Inductive load	-	-	400	ns	
Q _{rr} (Note1)	Reverse recovery charge	R _G =3.9 Ω, Inductive load	-	10.0	-	μC	
E _{on}	Turn-on switching energy per pulse	V _{CC} =600 V, I _C =I _E =100 A,	-	9.2	-	mJ	
E _{off}	Turn-off switching energy per pulse	V _{GE} =±15 V, R _G =3.9 Ω, T _{vj} =150 °C,	-	10.6	-		
E _{rr} (Note1)	Reverse recovery energy per pulse	Inductive load	-	5.7	-	mJ	
r _g	Internal gate resistance	Per switch	-	0	-	Ω	

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I _{CEs}	Collector-emitter cut-off current	V _{CE} =V _{CEs} , G-E short-circuited	-	-	1.0	mA	
I _{GES}	Gate-emitter leakage current	V _{GE} =V _{GES} , C-E short-circuited	-	-	0.5	μA	
V _{GE(th)}	Gate-emitter threshold voltage	I _C =7.5 mA, V _{CE} =10 V	5.4	6.0	6.6	V	
V _{CEsat} (Terminal)	Collector-emitter saturation voltage	I _C =75 A, V _{GE} =15 V, Refer to the figure of test circuit (Note5)	T _{vj} =25 °C	-	1.75	2.20	V
			T _{vj} =125 °C	-	2.05	-	
			T _{vj} =150 °C	-	2.15	-	
V _{CEsat} (Chip)	Collector-emitter saturation voltage	I _C =75 A, V _{GE} =15 V, (Note5)	T _{vj} =25 °C	-	1.60	1.85	V
			T _{vj} =125 °C	-	1.75	-	
			T _{vj} =150 °C	-	1.80	-	
C _{ies}	Input capacitance	V _{CE} =10 V, G-E short-circuited	-	-	18.2	nF	
C _{oes}	Output capacitance		-	-	0.5		
C _{res}	Reverse transfer capacitance		-	-	0.2		
Q _G	Gate charge	V _{CC} =600 V, I _C =75 A, V _{GE} =15 V	-	0.57	-	μC	
t _{d(on)}	Turn-on delay time	V _{CC} =600 V, I _C =75 A, V _{GE} =±15 V, R _G =5.6 Ω, Inductive load	-	-	500	ns	
t _r	Rise time		-	-	150		
t _{d(off)}	Turn-off delay time		-	-	500		
t _f	Fall time		-	-	400		

CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

ELECTRICAL CHARACTERISTICS (cont.; T_{vj}=25 °C, unless otherwise specified)

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions	Limits			Unit		
			Min.	Typ.	Max.			
E _{on}	Turn-on switching energy per pulse	V _{CC} =600 V, V _{GE} =±15 V, T _{vj} =150 °C, Inductive load	I _C =75 A, R _G =5.6 Ω	-	6.1	-	mJ	
E _{off}	Turn-off switching energy per pulse			-	7.8	-		
E _{rr}	Reverse recovery energy per pulse			I _E =75 A, R _G =5.6 Ω	-	3.9		-
r _g	Internal gate resistance	-	-	4.0	-	Ω		
I _{RRM}	Reverse current	V _R =V _{RRM} , G-E short-circuited	-	-	1.0	mA		
V _F (Terminal)	Forward voltage	I _F =50 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T _{vj} =25 °C	-	1.75	2.40	V	
				T _{vj} =125 °C	-	1.95		-
				T _{vj} =150 °C	-	2.00		-
V _F (Chip)	Forward voltage	I _F =50 A, G-E short-circuited, (Note5)	T _{vj} =25 °C	-	1.65	2.10	V	
				T _{vj} =125 °C	-	1.65		-
				T _{vj} =150 °C	-	1.65		-
t _{rr}	Reverse recovery time	V _{CC} =600 V, I _F =50 A, V _{GE} =±15 V,	-	-	400	ns		
Q _{rr}	Reverse recovery charge	R _G =15 Ω, Inductive load	-	5.0	-	μC		

CONVERTER PART DIODE

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
I _{RRM}	Repetitive peak reverse current	V _R =V _{RRM} , T _{vj} =150 °C	-	-	20	mA	
V _F (Terminal)	Forward voltage	I _F =100 A	T _{vj} =25 °C	-	1.35	1.80	V
			T _{vj} =150 °C	-	1.30	-	
V _F (chip)			T _{vj} =25 °C	-	1.15	1.40	
			T _{vj} =150 °C	-	1.10	-	

NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R ₂₅	Zero-power resistance	T _C =25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R ₁₀₀ =493 Ω, T _C =100 °C (Note4)	-7.3	-	+7.8	%
B _(25/50)	B-constant	Approximate by equation (Note6)	-	3375	-	K
P ₂₅	Power dissipation	T _C =25 °C (Note4)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
R _{th(j-c)Q}	Thermal resistance	Junction to case, per Inverter IGBT (Note4)	-	-	264	K/kW	
R _{th(j-c)D}		Junction to case, per Inverter FWD (Note4)	-	-	480		
R _{th(j-c)Q}		Junction to case, Brake IGBT (Note4)	-	-	339		
R _{th(j-c)D}		Junction to case, Brake DIODE (Note4)	-	-	804		
R _{th(j-c)D}		Junction to case, per Converter DIODE (Note4)	-	-	538		
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, per 1 module,	Thermal grease applied (Note4, 7)		-	11.5	K/kW
			PC-TIM applied (Note4, 8)		-	3.1	

CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit	
			Min.	Typ.	Max.		
M _s	Mounting torque	Mounting to heat sink M 5 screw	2.5	3.0	3.5	N·m	
d _s	Creepage distance	Solder pin type(MXUC)	Terminal to terminal	16.5	-	-	mm
			Terminal to base plate	18.3	-	-	
		Pressfit pin type(MXUCP)	Terminal to terminal	9.0	-	-	
			Terminal to base plate	15.8	-	-	
d _a	Clearance	Solder pin type(MXUC)	Terminal to terminal	10.3	-	-	
			Terminal to base plate	18.1	-	-	
		Pressfit pin type(MXUCP)	Terminal to terminal	8.8	-	-	
			Terminal to base plate	15.8	-	-	
e _c	Flatness of base plate	On the centerline X, Y (Note9)	±0	-	+200	µm	
m	mass	-	-	270	-	g	

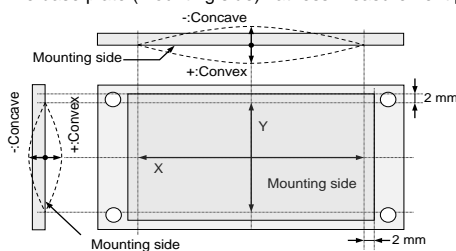
RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V _{CC}	(DC) Supply voltage	Applied across P-N(P1-N1) terminals	-	600	850	V
V _{GEon}	Gate (-emitter drive) voltage	Applied across G*P-*/G*N-E/GB-E terminals (*=U,V,W)	13.5	15.0	16.5	V
R _G	External gate resistance	Inverter IGBT, Per switch	3.9	-	40	Ω
		Brake IGBT	5.6	-	56	

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

- Junction temperature (T_{vj}) should not increase beyond T_{vjmax} rating.
- Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.
- Case temperature (T_C) and heat sink temperature (T_S) are defined on the each surface (mounting side) of base plate and heat sink just under the chips.
Refer to the figure of chip location.
- Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.
- $B_{(25/50)} = \ln\left(\frac{R_{25}}{R_{50}}\right) / \left(\frac{1}{T_{25}} - \frac{1}{T_{50}}\right)$
R₂₅: resistance at absolute temperature T₂₅ [K]; T₂₅=25 [°C]+273.15=298.15 [K]
R₅₀: resistance at absolute temperature T₅₀ [K]; T₅₀=50 [°C]+273.15=323.15 [K]
- Typical value is measured by using thermally conductive grease of λ=0.9 W/(m·K)/D_(C-S)=50 µm.
- Typical value is measured by using PC-TIM of λ=3.4 W/(m·K)/D_(C-S)=50 µm.
- The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



- Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

PCB thickness : t1.6

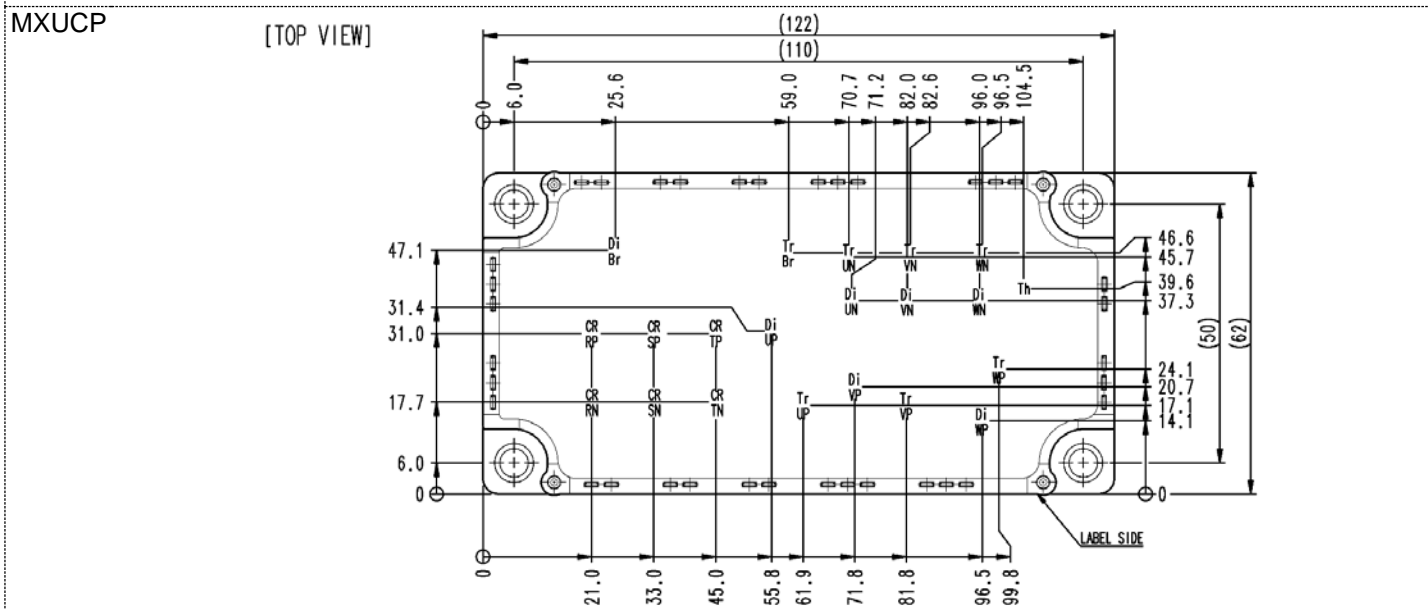
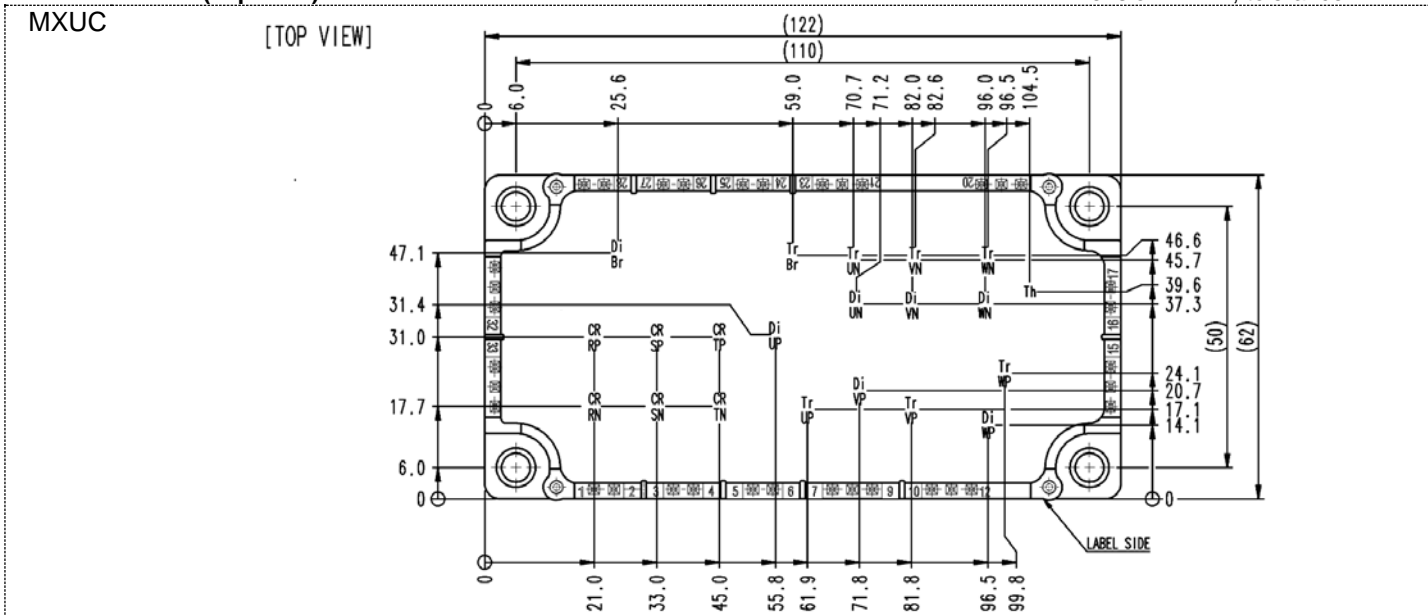
Type	Manufacturer	Size	Tightening torque (N·m)	Recommended tightening method
(1) PT®	EJOT	K25x8	0.55 ± 0.055	by handwork (equivalent to 30 rpm by mechanical screw driver) ~ 600 rpm (by mechanical screw driver)
(2) PT®		K25x10	0.75 ± 0.075 N·m	
(3) DELTA PT®		25x8	0.55 ± 0.055 N·m	
(4) DELTA PT®		25x10	0.75 ± 0.075 N·m	
(5) B1 tapping screw	-	φ2.6x10 φ2.6x12	0.75 ± 0.075 N·m	

CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

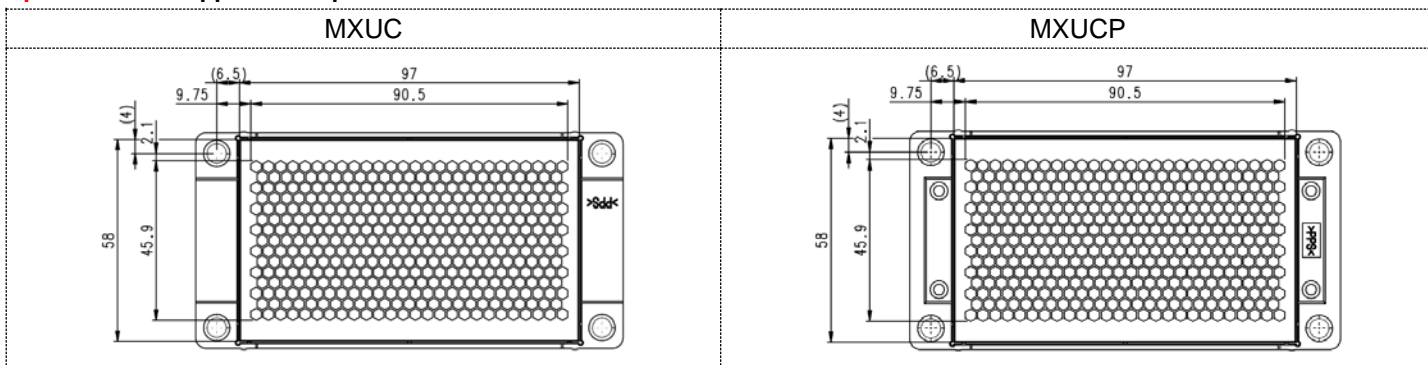
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

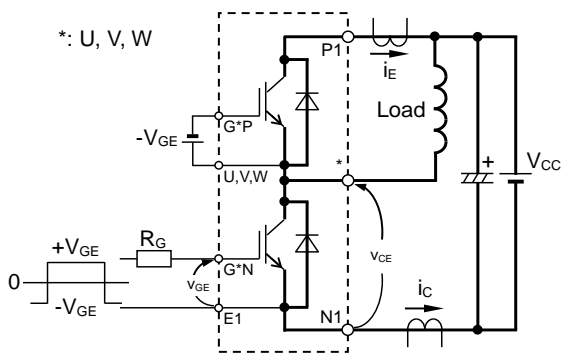


Tr*P/Tr*N/Tr*Br: IGBT, Di*P/Di*N: DIODE (*=U/V/W), DiBr: BRAKE DIODE,
CR*P/CR*N: CONVERTER DIODE (*=R/S/T), Th: NTC thermistor

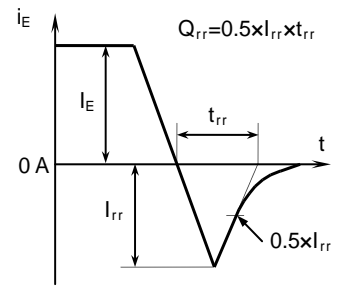
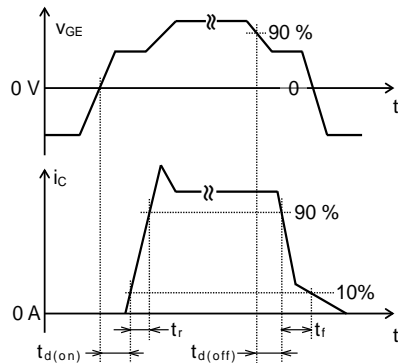
Option: PC-TIM applied baseplate outline



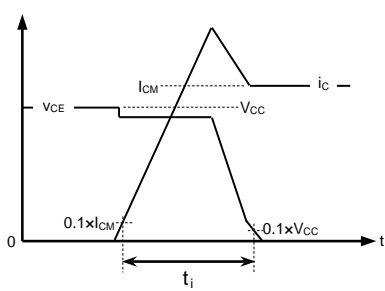
TEST CIRCUIT AND WAVEFORMS



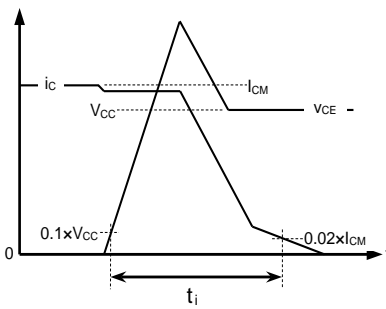
Switching characteristics test circuit and waveforms



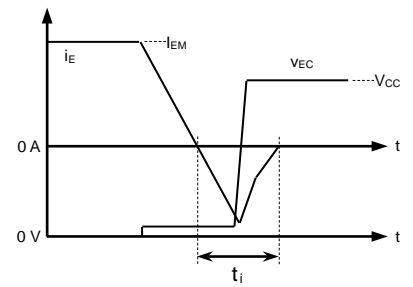
t_{rr} , Q_{rr} characteristics test waveform



IGBT Turn-on switching energy



IGBT Turn-off switching energy



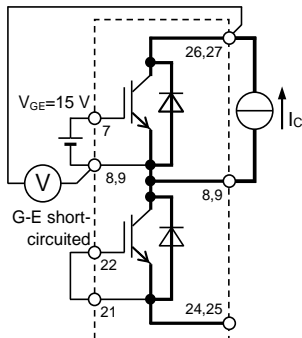
FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

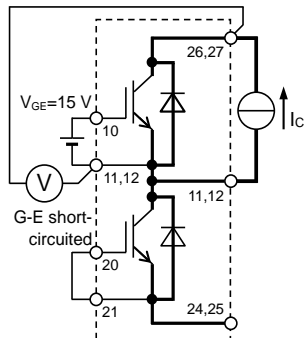
CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

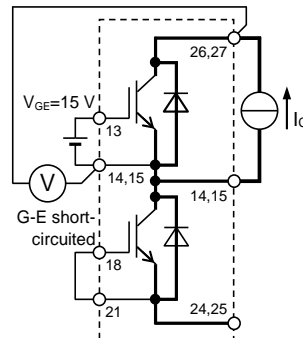
TEST CIRCUIT



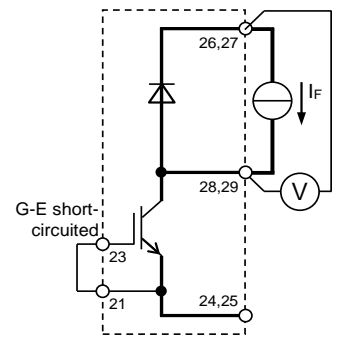
TrUP



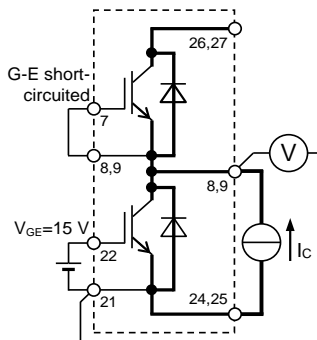
TrVP



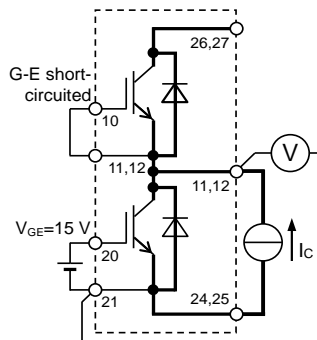
TrWP



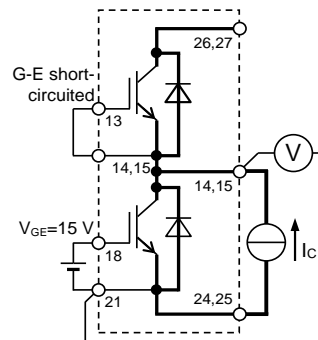
Brake DIODE



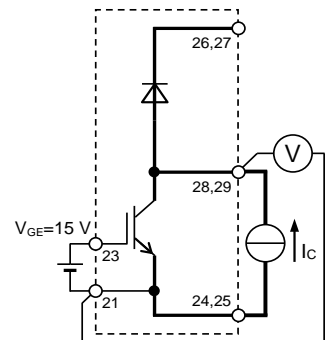
TrUN



TrVN



TrWN



Brake IGBT

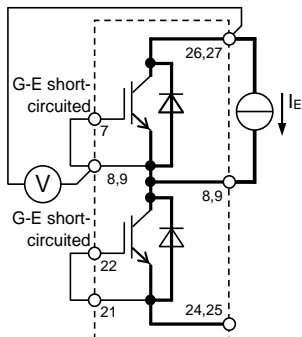
Gate-emitter GVP-V, GVN-E1,
short-circuited GWP-W, GWN-E1
GB-E1

Gate-emitter GUP-U, GUN-E1,
short-circuited GWP-W, GWN-E1
GB-E1

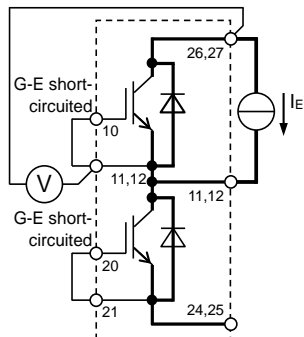
Gate-emitter GUP-U, GUN-E1,
short-circuited GVP-V, GVN-E1
GB-E1

Gate-emitter GUP-U, GUN-E1,
short-circuited GVP-V, GVN-E1,
GWP-W, GWN-E1

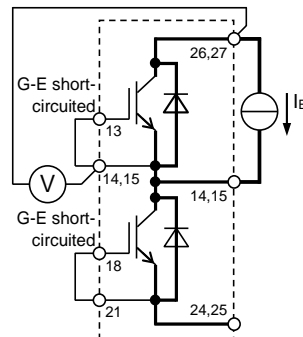
V_{CEsat} /BRAKE DIODE V_F characteristics test circuit



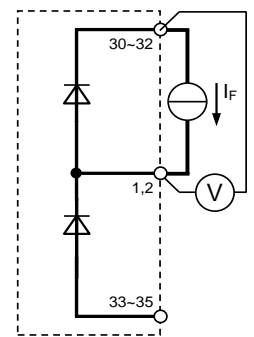
DiUP



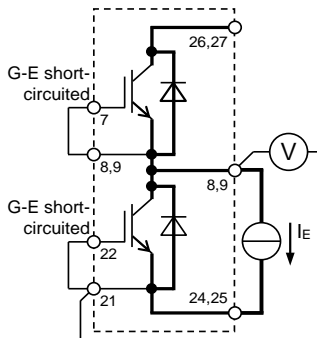
DiVP



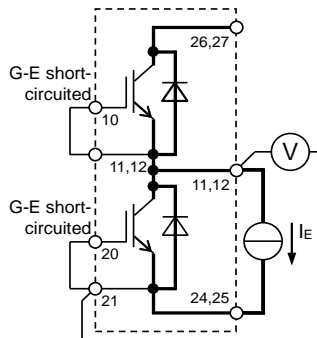
DiWP



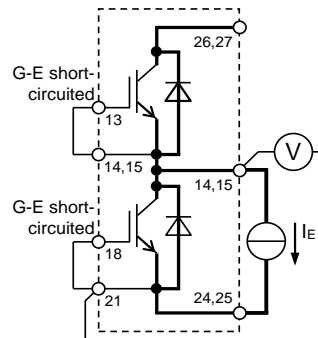
CONVERTER DIODE (ex.phase-R)



DiUN



DiVN



DiWN

Gate-emitter GVP-V, GVN-E1,
short-circuited GWP-W, GWN-E1
GB-E1

Gate-emitter GUP-U, GUN-E1,
short-circuited GWP-W, GWN-E1
GB-E1

Gate-emitter GUP-U, GUN-E1,
short-circuited GVP-V, GVN-E1
GB-E1

V_{EC} / CONVERTER DIODE V_F characteristics test circuit

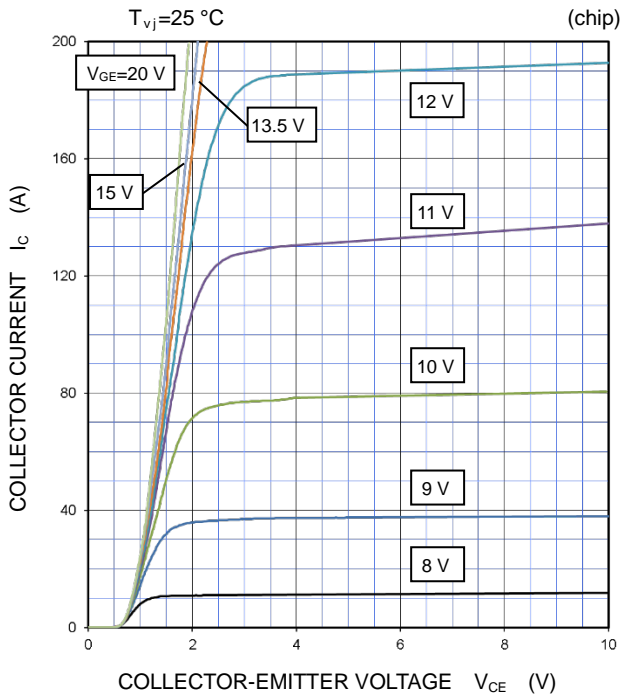
CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

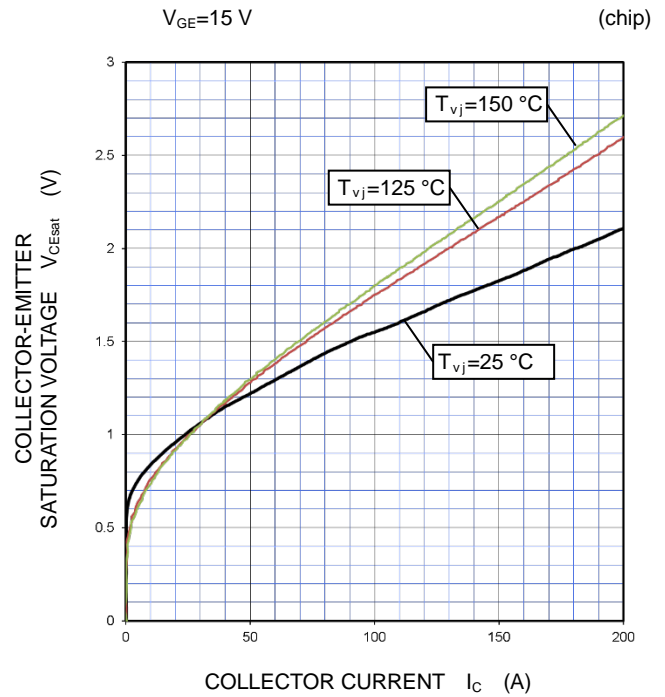
PERFORMANCE CURVES

INVERTER PART

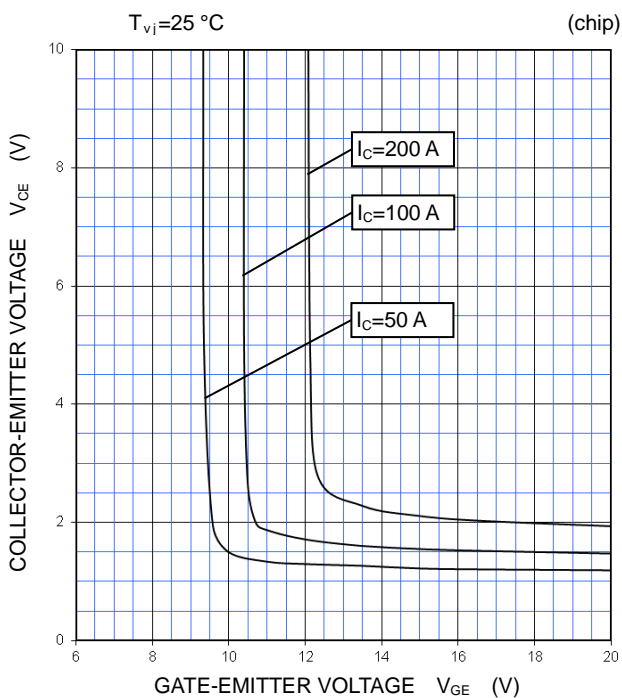
OUTPUT CHARACTERISTICS (TYPICAL)



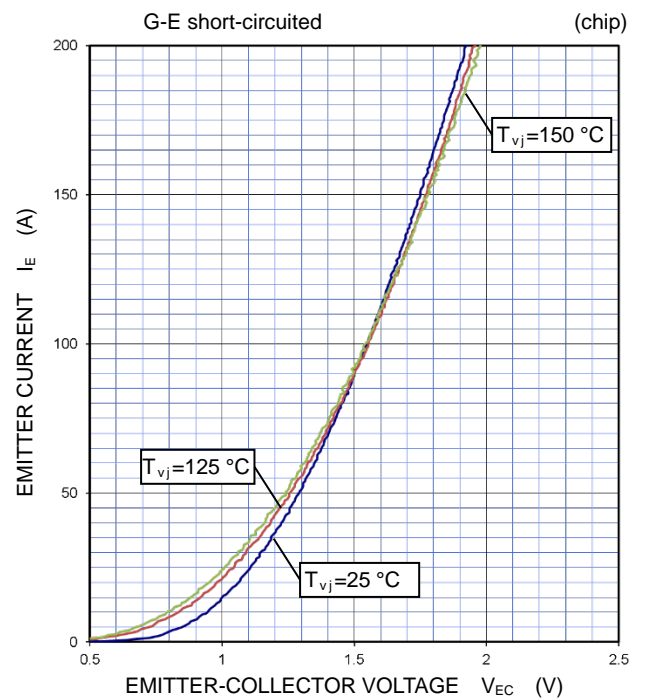
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)



CM100MXUC-24T/CM100MXUCP-24T

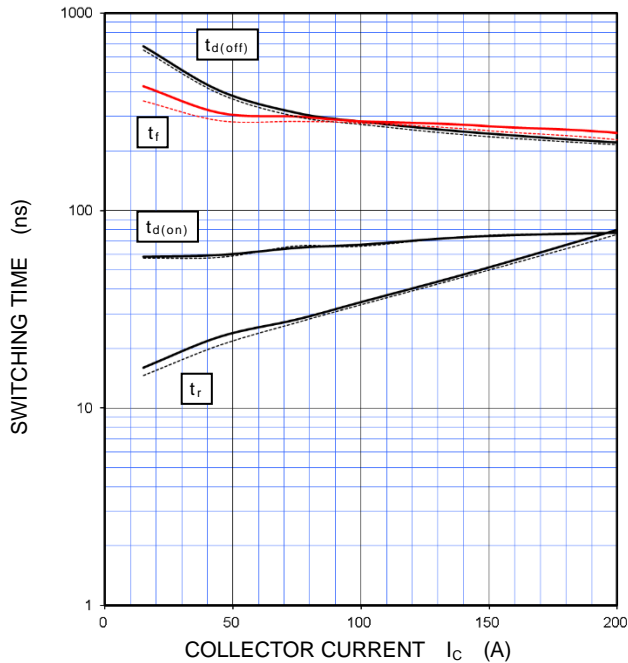
HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

INVERTER PART

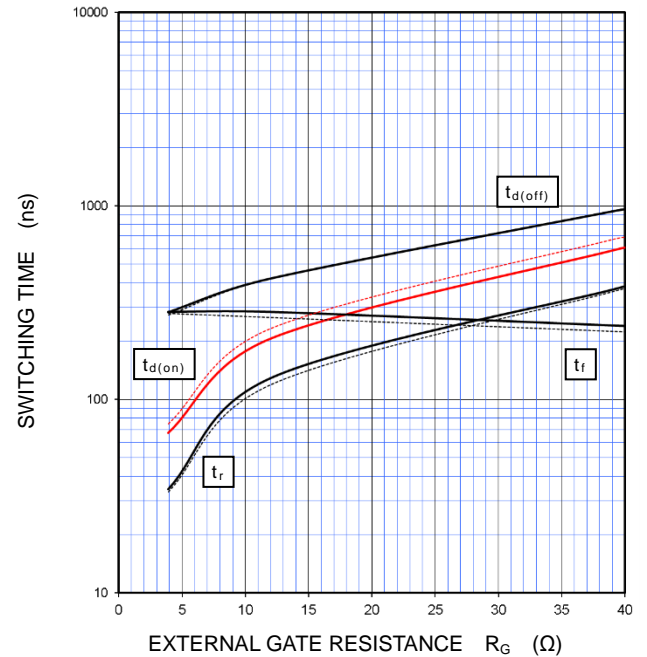
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $R_G=3.9\ \Omega$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$



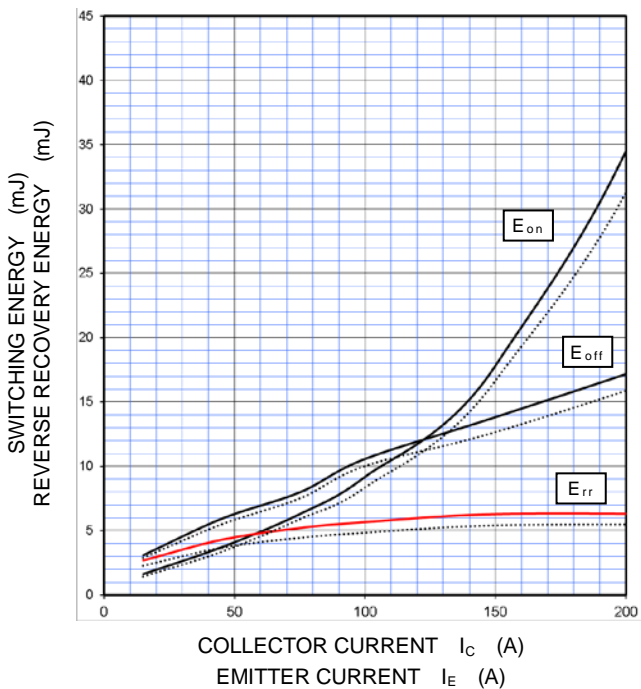
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $I_C=100\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$



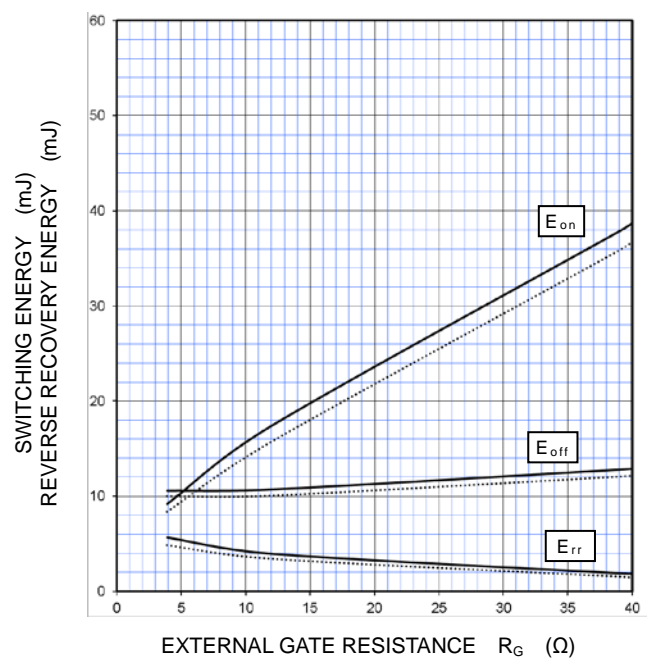
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $R_G=3.9\ \Omega$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD,
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$, PER PULSE



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $I_C/I_E=100\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD,
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$, PER PULSE



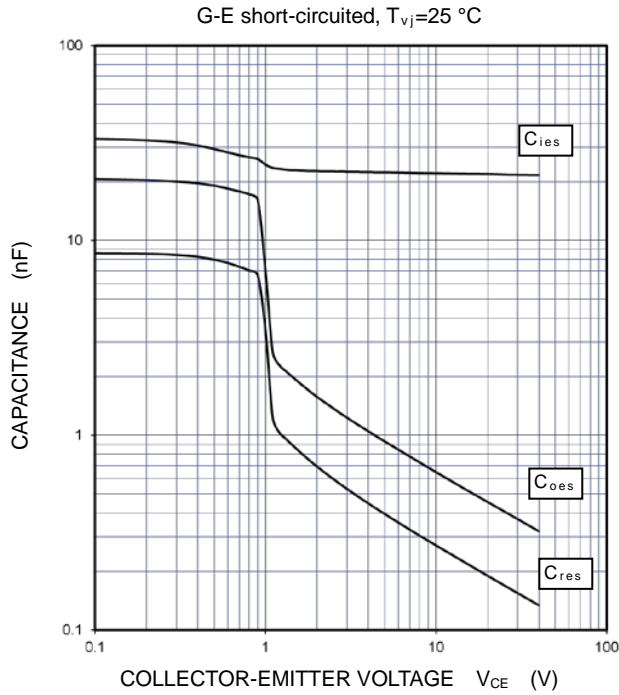
CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

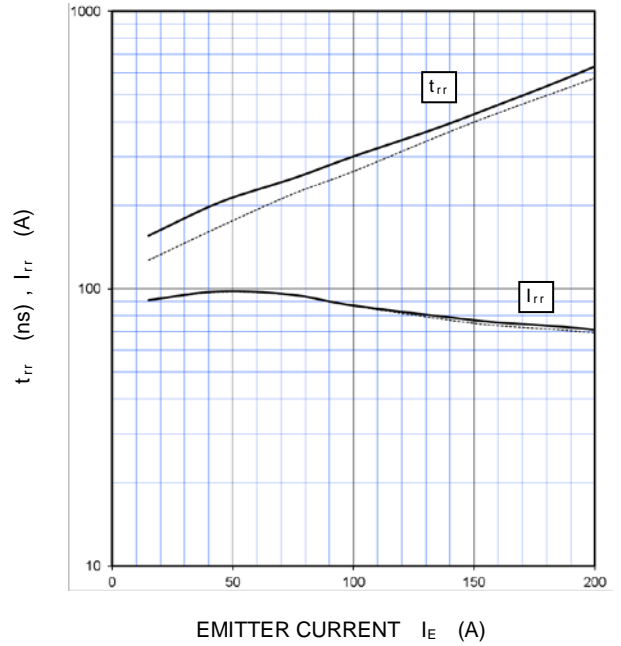
INVERTER PART

CAPACITANCE CHARACTERISTICS (TYPICAL)

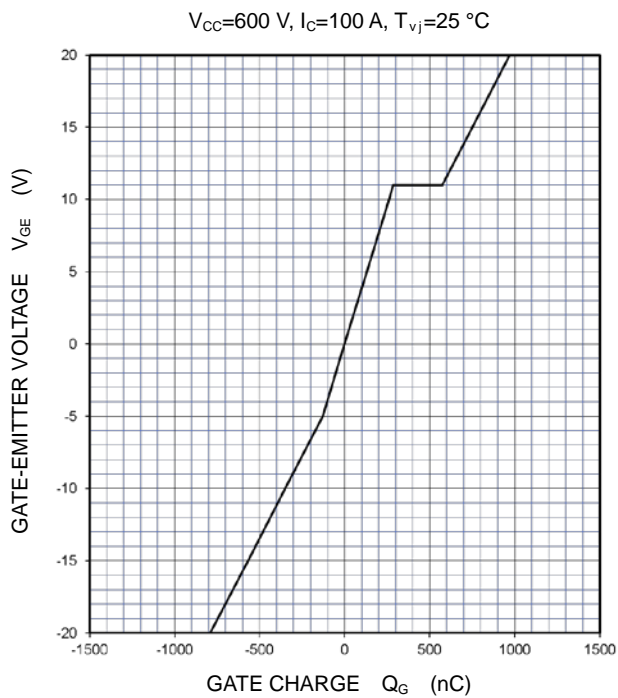


FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $R_G=3.9\text{ }\Omega$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
—: $T_j=150\text{ }^{\circ}\text{C}$, - - - -: $T_j=125\text{ }^{\circ}\text{C}$

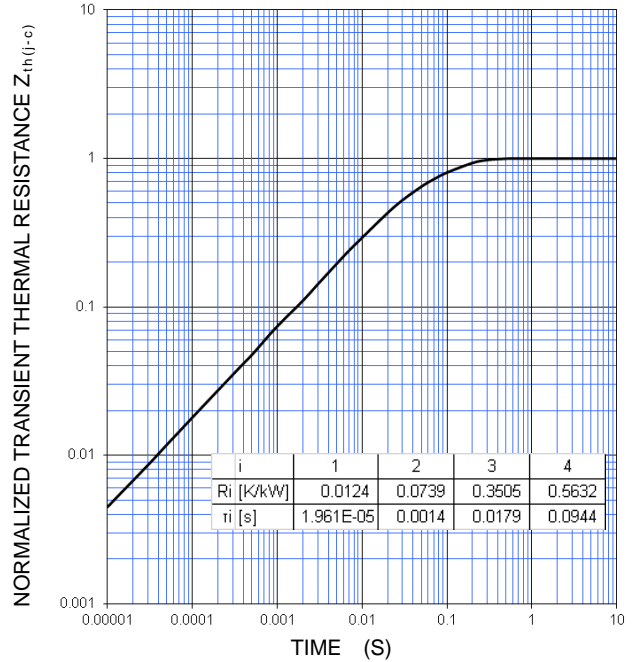


GATE CHARGE CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

Single pulse, $T_C=25\text{ }^{\circ}\text{C}$
 $R_{th(j-c)Q}=264\text{ K/kW}$, $R_{th(j-c)D}=480\text{ K/kW}$



CM100MXUC-24T/CM100MXUCP-24T

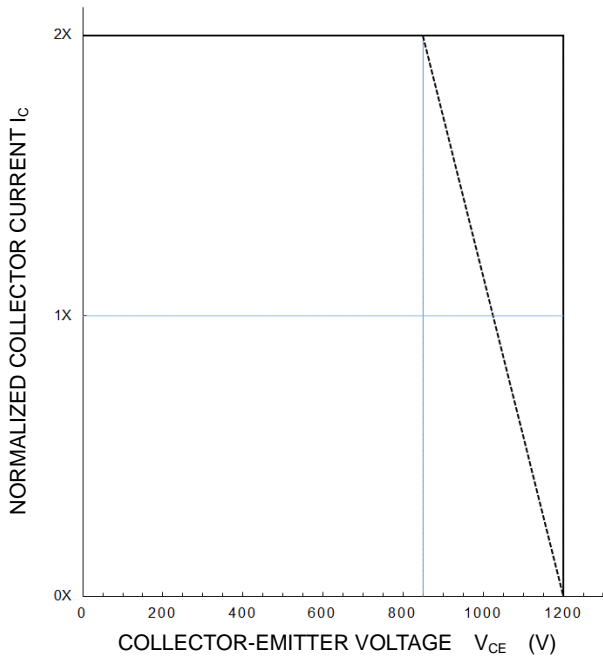
HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

INVERTER PART

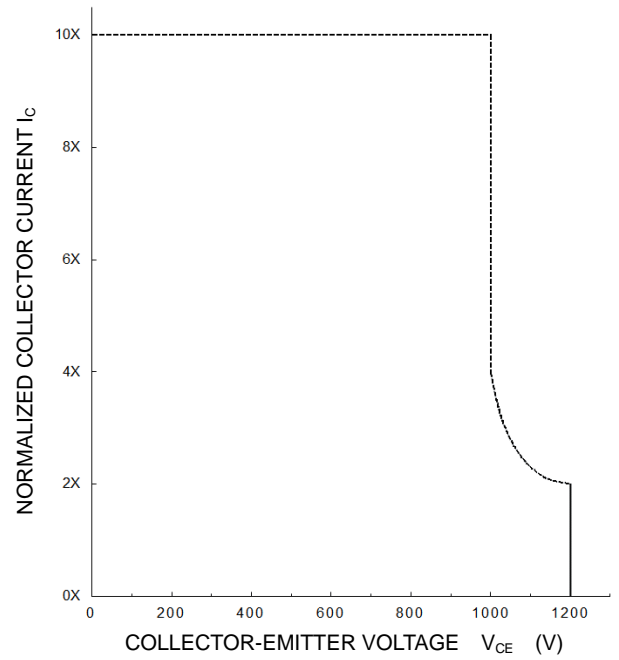
**TURN-OFF SWITCHING SAFE OPERATING AREA
(REVERSE BIAS SAFE OPERATING AREA)
(MAXIMUM)**

$V_{CC} \leq 850 \text{ V}$, $R_G = 3.9 \sim 40 \ \Omega$, $V_{GE} = \pm 15 \text{ V}$,
——: $T_{vj} = 25 \sim 150 \text{ }^\circ\text{C}$ (Normal load operations (Continuous))
- - - - -: $T_{vj} = 175 \text{ }^\circ\text{C}$ (Unusual load operations (Limited period))



**SHORT-CIRCUIT SAFE OPERATING AREA
(MAXIMUM)**

$V_{CC} \leq 800 \text{ V}$, $R_G = 3.9 \sim 40 \ \Omega$, $V_{GE} = \pm 15 \text{ V}$,
 $T_{vj} = 25 \sim 150 \text{ }^\circ\text{C}$, $t_W \leq 8 \ \mu\text{s}$, Non-Repetitive



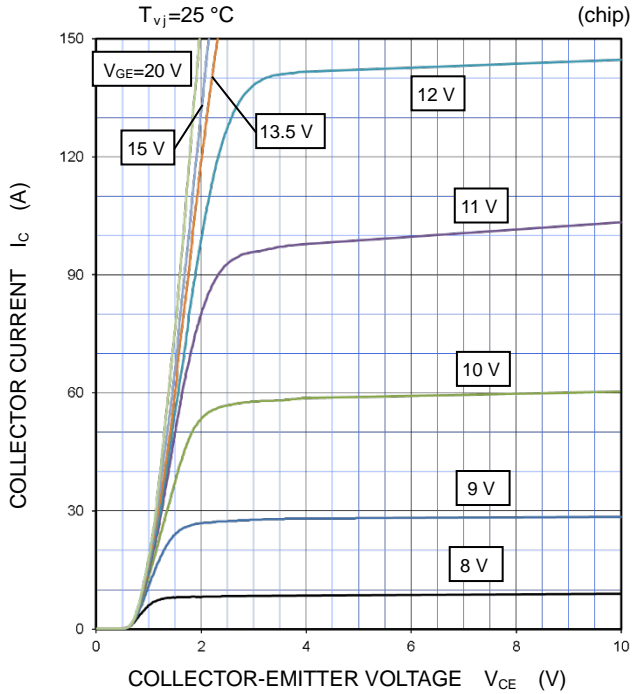
CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

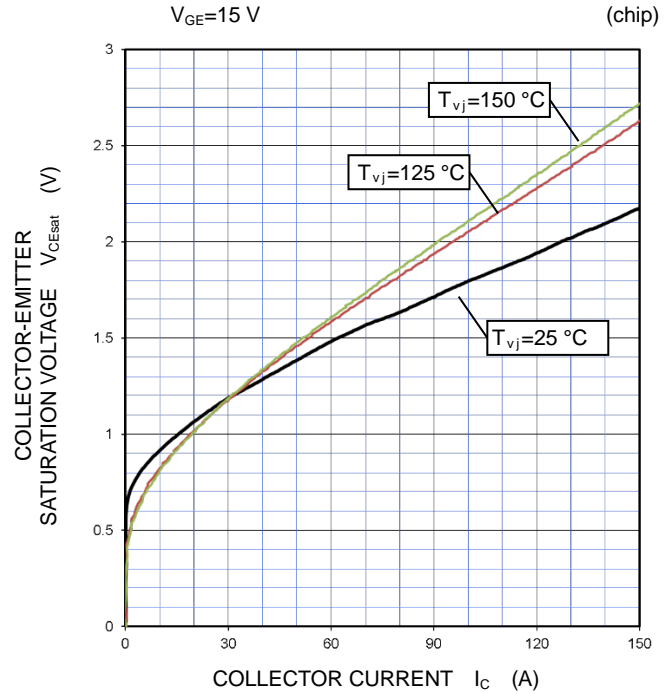
PERFORMANCE CURVES

BRAKE PART

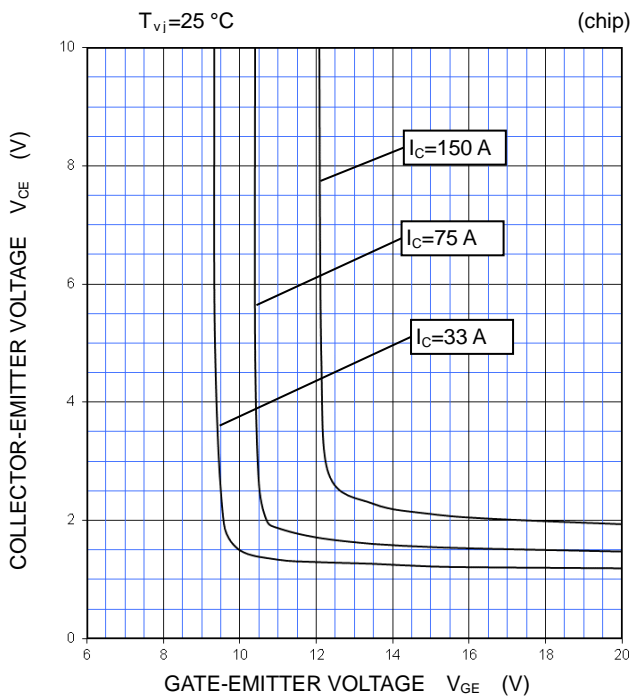
OUTPUT CHARACTERISTICS (TYPICAL)



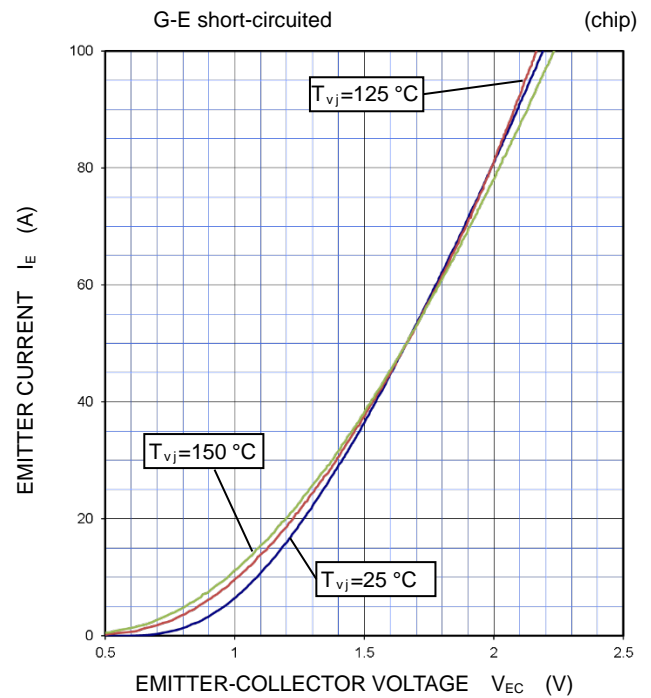
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)



DIODE FORWARD CHARACTERISTICS (TYPICAL)



CM100MXUC-24T/CM100MXUCP-24T

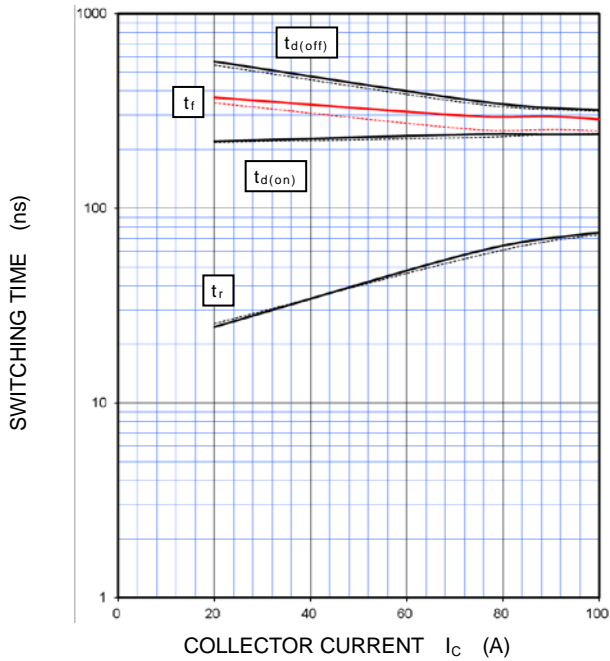
HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

BRAKE PART

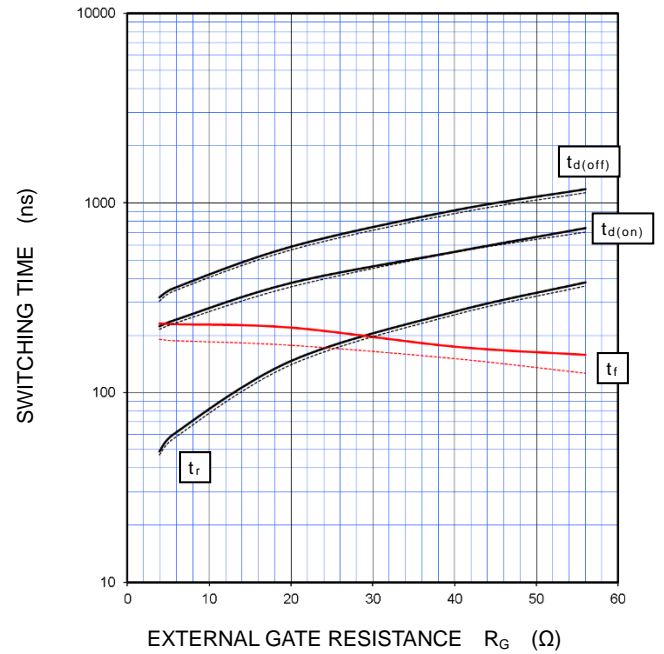
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $R_G=5.6\ \Omega$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$



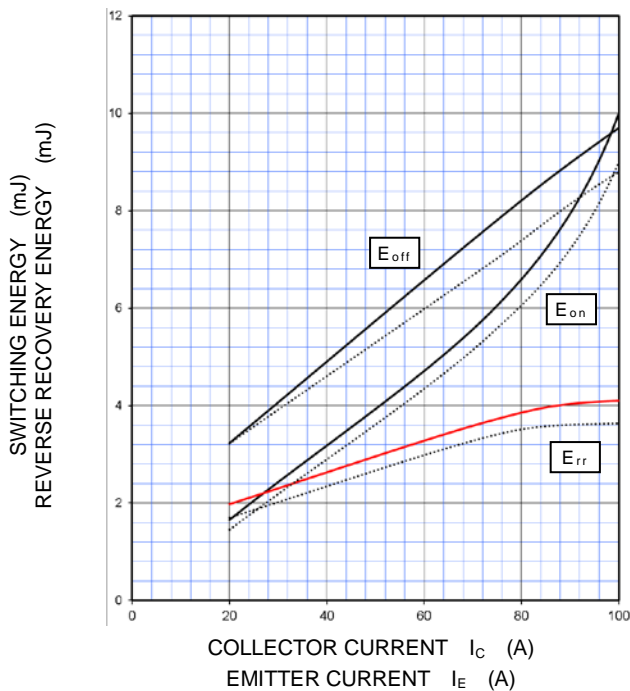
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $I_c=75\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$



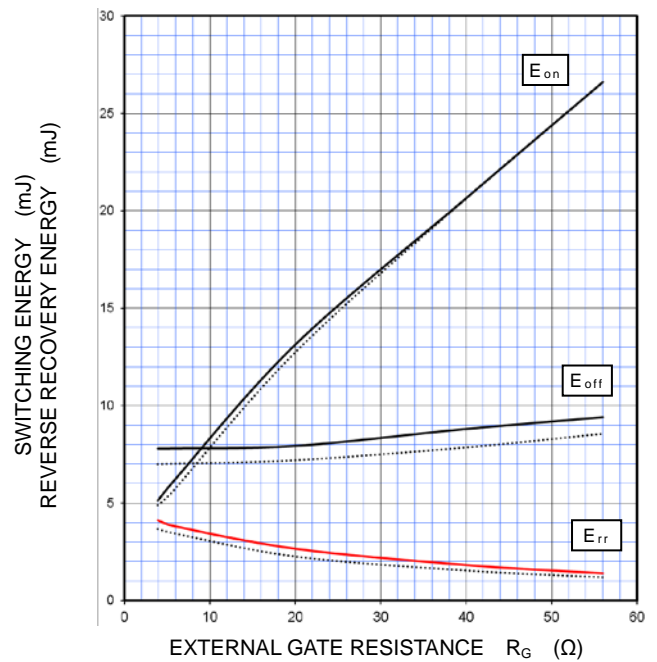
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $R_G=5.6\ \Omega$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD, PER PULSE
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

$V_{CC}=600\text{ V}$, $I_c/I_E=75\text{ A}$, $V_{GE}=\pm 15\text{ V}$, INDUCTIVE LOAD, PER PULSE
 —: $T_{vj}=150\text{ }^\circ\text{C}$, - - - -: $T_{vj}=125\text{ }^\circ\text{C}$



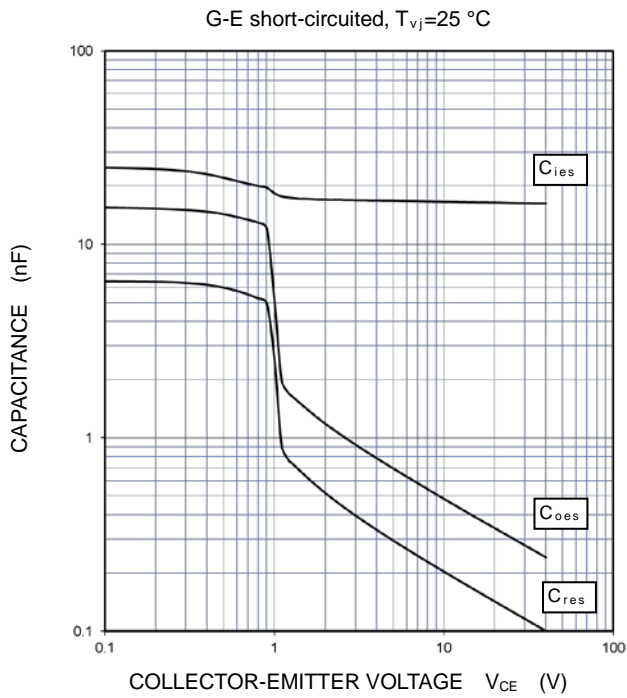
CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

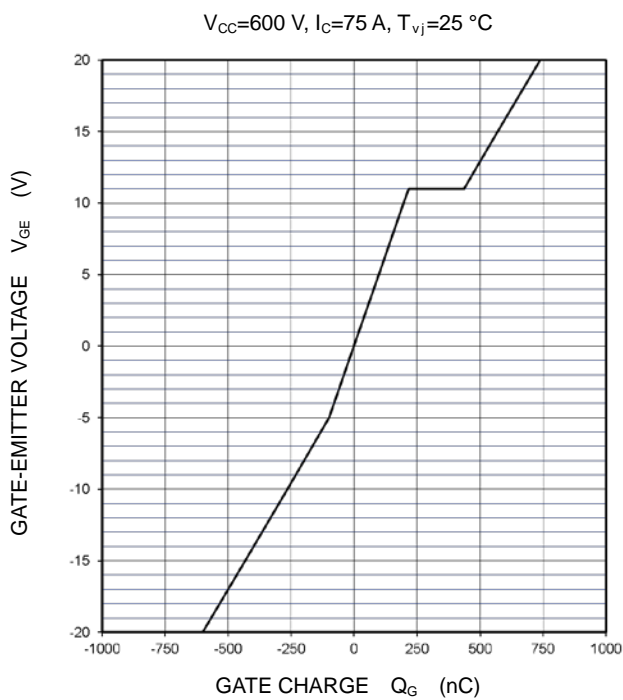
PERFORMANCE CURVES

BRAKE PART

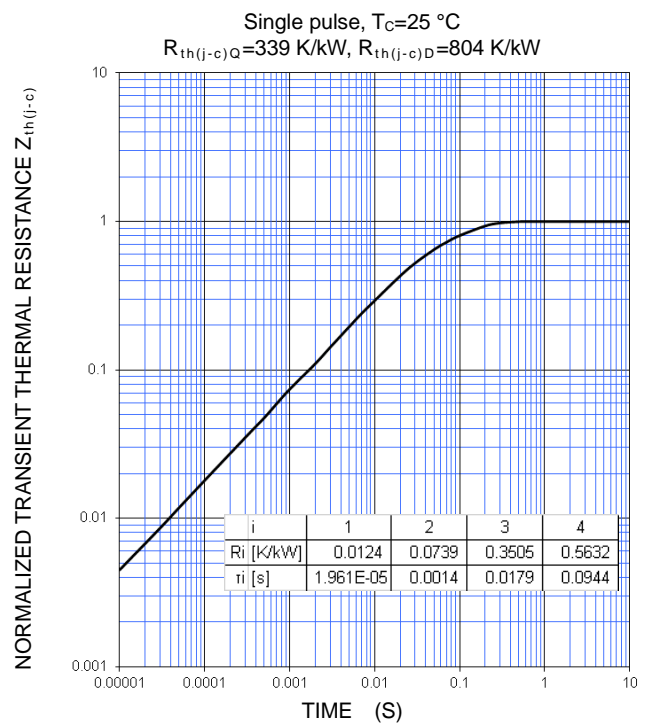
CAPACITANCE CHARACTERISTICS (TYPICAL)



GATE CHARGE CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)



CM100MXUC-24T/CM100MXUCP-24T

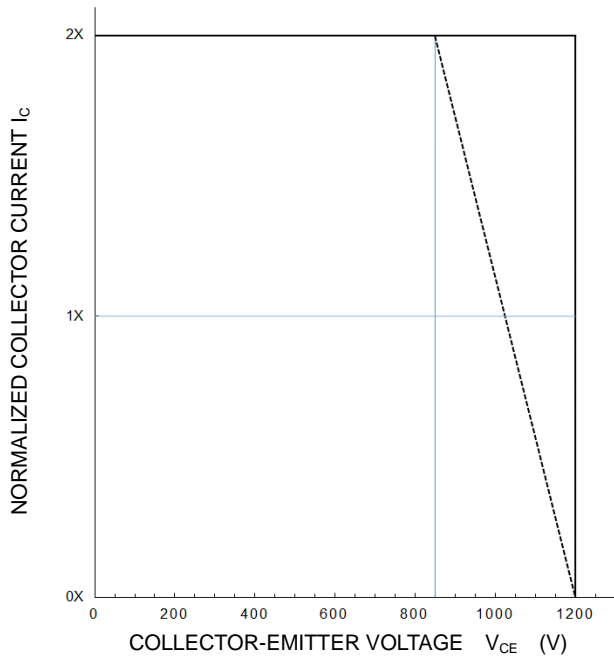
HIGH POWER SWITCHING USE
INSULATED TYPE

PERFORMANCE CURVES

BRAKE PART

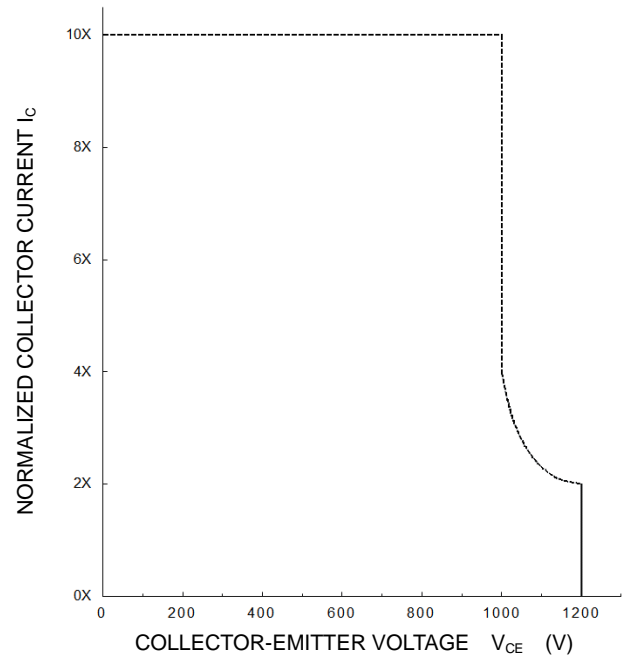
**TURN-OFF SWITCHING SAFE OPERATING AREA
(REVERSE BIAS SAFE OPERATING AREA)
(MAXIMUM)**

$V_{CC} \leq 850 \text{ V}$, $R_G = 5.6 \sim 56 \ \Omega$, $V_{GE} = \pm 15 \text{ V}$,
 ———: $T_{vj} = 25 \sim 150 \text{ }^\circ\text{C}$ (Normal load operations (Continuous))
 - - - - -: $T_{vj} = 175 \text{ }^\circ\text{C}$ (Unusual load operations (Limited period))



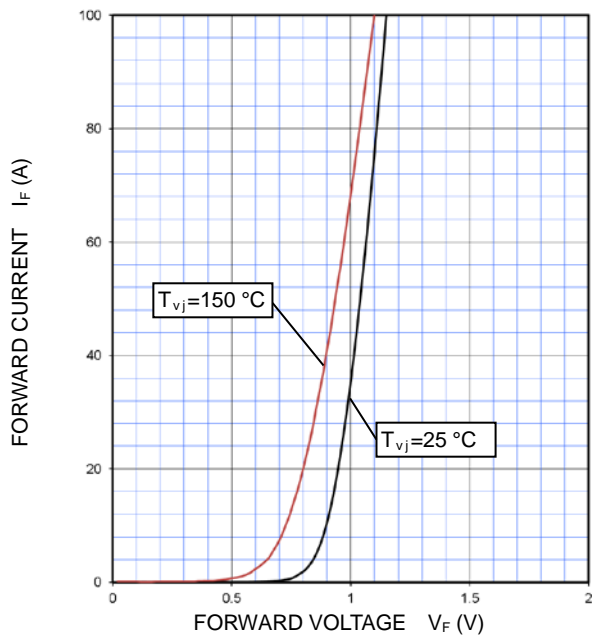
**SHORT-CIRCUIT SAFE OPERATING AREA
(MAXIMUM)**

$V_{CC} \leq 800 \text{ V}$, $R_G = 5.6 \sim 56 \ \Omega$, $V_{GE} = \pm 15 \text{ V}$,
 $T_{vj} = 25 \sim 150 \text{ }^\circ\text{C}$, $t_{W} \leq 8 \ \mu\text{s}$, Non-Repetitive



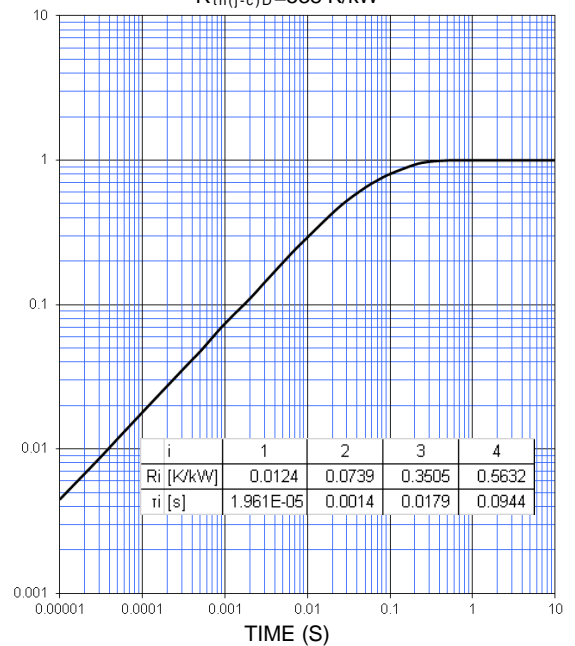
CONVERTER PART

**CONVERTER DIODE
FORWARD CHARACTERISTICS
(TYPICAL)**



**TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS
(MAXIMUM)**

Single pulse, $T_C = 25 \text{ }^\circ\text{C}$
 $R_{th(j-c)D} = 538 \text{ K/kW}$



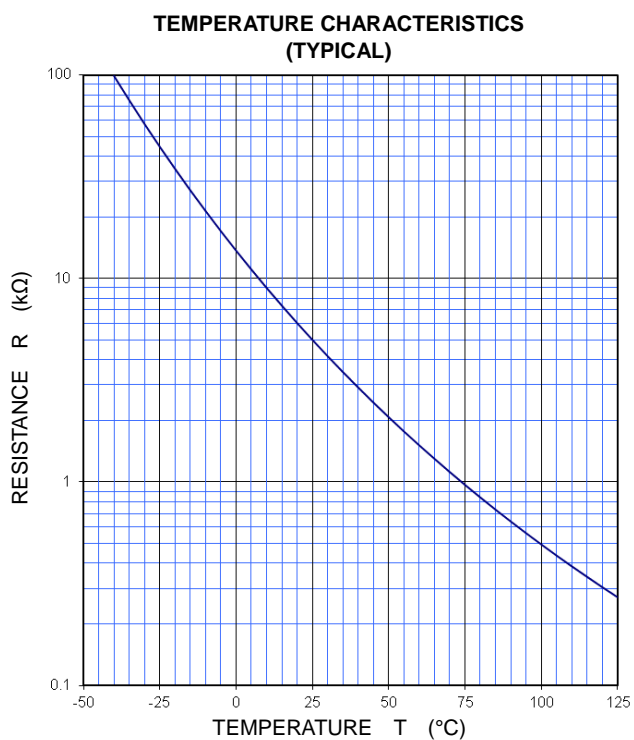
CM100MXUC-24T/CM100MXUCP-24T

HIGH POWER SWITCHING USE

INSULATED TYPE

PERFORMANCE CURVES

NTC thermistor part



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

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